Quad Array for ESD Protection

This quad monolithic silicon voltage suppressor is designed for applications requiring transient overvoltage protection capability. It is intended for use in voltage and ESD sensitive equipment such as computers, printers, business machines, communication systems, medical equipment, and other applications. Its quad junction common anode design protects four separate lines using only one package. These devices are ideal for situations where board space is at a premium.

Specification Features

- SOT-553 Package Allows Four Separate Unidirectional Configurations
- Low Leakage < 1 µA @ 3 V for NZQA5V6XV5T1G
- Breakdown Voltage: 5.6 V 6.8 V @ 1 mA
- ESD Protection Meeting IEC61000-4-2 Level 4
- These are Pb-Free Devices

Mechanical Characteristics

- Void Free, Transfer-Molded, Thermosetting Plastic Case
- Corrosion Resistant Finish, Easily Solderable
- Package Designed for Optimal Automated Board Assembly
- Small Package Size for High Density Applications
- 100% Lead Free, MSL1 @ 260°C Reflow Temperature



ON Semiconductor®

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SOT-553 CASE 463B PLASTIC

MARKING DIAGRAM

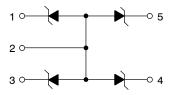


xx = Specific Device Code

M = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)



ORDERING INFORMATION

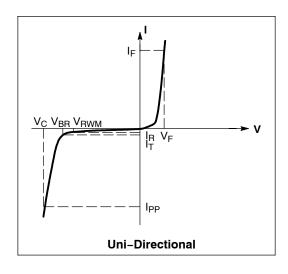
Device	Package	Shipping [†]
NZQA5V6XV5T1G	SOT-553 (Pb-Free)	4000 / Tape & Reel
NZQA5V6XV5T3G	SOT-553 (Pb-Free)	16000 / Tape & Reel
NZQA6V2XV5T1G	SOT-553 (Pb-Free)	4000 / Tape & Reel
NZQA6V8XV5T1G	SOT-553 (Pb-Free)	4000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS

(T_A = 25°C unless otherwise noted)

Symbol	Parameter			
I _{PP}	Maximum Reverse Peak Pulse Current			
V_{C}	Clamping Voltage @ I _{PP}			
V_{RWM}	Working Peak Reverse Voltage			
I _R Maximum Reverse Leakage Current @ V _{RV}				
V_{BR}	Breakdown Voltage @ I _T			
I _T	Test Current			
ΘV_{BR}	Maximum Temperature Coefficient of V _{BR}			
Ιϝ	Forward Current			
V _F	Forward Voltage @ I _F			
Z _{ZT}	Maximum Zener Impedance @ I _{ZT}			
I _{ZK}	Reverse Current			
Z _{ZK}	Maximum Zener Impedance @ I _{ZK}			



MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise noted)

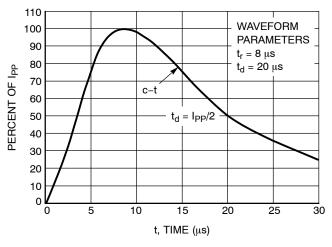
	Characteristic	Symbol	Value	Unit
Peak Power Dissipation	on (8 X 20 μs @ T _A = 25°C) (Note 1)	P _{PK}	100	W
Steady State Power -	1 Diode (Note 2)	P_{D}	300	mW
Thermal Resistance J Above 25°C, Derate		$R_{ hetaJA}$	370 2.7	°C/W mW/°C
Maximum Junction Te	mperature	T _{Jmax}	150	°C
Operating Junction ar	nd Storage Temperature Range	T _J T _{stg}	-55 to +150	°C
ESD Discharge	MIL STD 883C - Method 3015-6 IEC1000-4-2, Air Discharge IEC1000-4-2, Contact Discharge	V _{PP}	16 16 9	kV
Lead Solder Tempera	ture (10 seconds duration)	T_L	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

ELECTRICAL CHARACTERISTICS (T_A = 25°C)

	Device	Breakdown Voltage V _{BR} @ 1 mA (Volts)		Leakage Current		V _C Max @ I _{PP}		Typ Capacitance @ 0 V Bias (Note 3)	Max V _F @ I _F = 200 mA	
Device	Marking	Min	Nom	Max	V _{RWM}	I _{RWM} (μA)	V _C (V)	I _{PP} (A)	(pF)	(V)
NZQA5V6XV5T1G	56	5.32	5.6	5.88	3.0	1.0	10.5	10	90	1.3
NZQA6V2XV5T1G	62	5.89	6.2	6.51	4.0	0.5	11.5	9.0	80	1.3
NZQA6V8XV5T1G	68	6.46	6.8	7.14	4.3	0.1	12.5	8.0	70	1.3

- Non-repetitive current per Figure 1.
 Only 1 diode under power. For all 4 diodes under power, P_D will be 25%. Mounted on FR-4 board with min pad.
 Capacitance of one diode at f = 1 MHz, V_R = 0 V, T_A = 25°C



% OF RATED POWER OR IPP T_A, AMBIENT TEMPERATURE (°C)

Figure 1. Pulse Waveform

Figure 2. Power Derating Curve

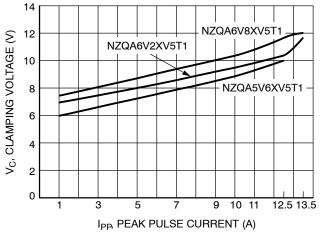


Figure 3. Clamping Voltage versus Peak Pulse Current

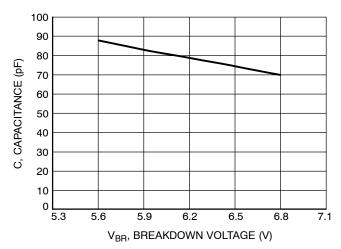
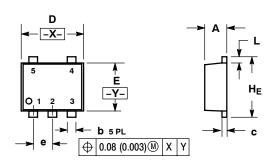


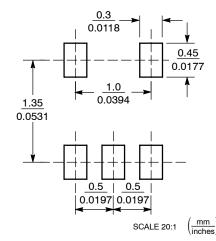
Figure 4. Typical Capacitance

PACKAGE DIMENSIONS

SOT-553, 5 LEAD CASE 463B-01 **ISSUE B**



SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

NOTES

- DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETERS
- MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL

	М	ILLIMETE	RS	INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.50	0.55	0.60	0.020	0.022	0.024	
b	0.17	0.22	0.27	0.007	0.009	0.011	
С	0.08	0.13	0.18	0.003	0.005	0.007	
D	1.50	1.60	1.70	0.059	0.063	0.067	
E	1.10	1.20	1.30	0.043	0.047	0.051	
е	0.50 BSC				0.020 BS0		
L	0.10	0.20	0.30	0.004	0.008	0.012	
HE	1.50	1.60	1.70	0.059	0.063	0.067	

STYLE 1: STYLE 2: PIN 1. BASE 2. EMITTER

PIN 1. CATHODE
2. COMMON ANODE
3. CATHODE 2
4. CATHODE 3

3 BASE 4. COLLECTOR

5. COLLECTOR 5. CATHODE 4

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